

Description

The VST04N014 **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\text{DS(ON)}}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

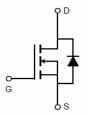
General Features

- V_{DS} =40V, I_D =170A $R_{DS(ON)}$ =1.4m Ω (typical) @ V_{GS} =10V
- Excellent gate charge x R_{DS(on)} product(FOM)
- Very low on-resistance R_{DS(on)}
- 175°C operating temperature
- Pb-free lead plating
- 100% UIS tested

Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification





TO-247

Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VST04N014-T7	VST04N014	TO-247	-	-	-

Absolute Maximum Ratings (T_c=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	40	V	
Gate-Source Voltage	V _G s	±20	V	
Drain Current-Continuous (Silicon Limited)	I _D	170	А	
Drain Current-Continuous(T _C =100 °C)	I _D (100°C)	120	Α	
Pulsed Drain Current (Package Limited)	I _{DM}	680	А	
Maximum Power Dissipation	P _D	250	W	
Derating factor		1.67	W/°C	
Single pulse avalanche energy (Note 5)	E _{AS}	1200	mJ	
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55 To 175	°C	

Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	R _{0JC}	0.6	°C/W
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Electrical Characteristics (T_C=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	40		-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V,V _{GS} =0V	-	-	1	μA	
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA	
On Characteristics (Note 3)			•				
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0	2.5	3.0	V	
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =85A	-	1.4	1.7	mΩ	
Forward Transconductance	g FS	V _{DS} =5V,I _D =85A	-	80	-	S	
Dynamic Characteristics (Note4)			•				
Input Capacitance	C _{lss}	.,	-	5670	-	PF	
Output Capacitance	C _{oss}	V_{DS} =20V, V_{GS} =0V, F=1.0MHz	-	1930	-	PF	
Reverse Transfer Capacitance	C _{rss}	r-1.0lvinz	-	62	-	PF	
Switching Characteristics (Note 4)	·		•				
Turn-on Delay Time	t _{d(on)}	V _{DD} =20V,I _D =85A	-	13.5	-	nS	
Turn-on Rise Time	t _r		-	7.2	-	nS	
Turn-Off Delay Time	Delay Time $t_{d(off)}$ V_{GS} =10V, R_{G} =1.6 Ω		-	55	-	nS	
Turn-Off Fall Time	t _f		-	8.6	-	nS	
Total Gate Charge	Qg	V _{DS} =20V,I _D =85A,	-	88.6	-	nC	
Gate-Source Charge	Q _{gs}	$V_{DS}=20V,I_{D}=65A,$ $V_{GS}=10V$	-	16		nC	
Gate-Drain Charge	Q_{gd}	VGS-10V	-	13		nC	
Drain-Source Diode Characteristics	·		•				
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =85A	-		1.2	V	
Diode Forward Current (Note 2)	Is		-	-	170	Α	
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C, I_F = I_S$	-		33	nS	
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-		119	nC	

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25 $^{\circ}\!\!\mathrm{C}$,V $_{DD}$ =20V ,V $_{G}$ =10V ,L=0.5mH ,Rg=25 Ω





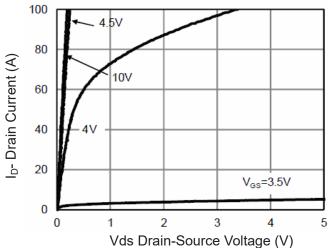


Figure 1 Output Characteristics

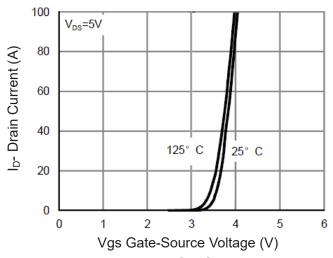


Figure 2 Transfer Characteristics

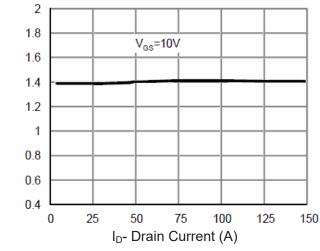


Figure 3 Rdson-Drain Current

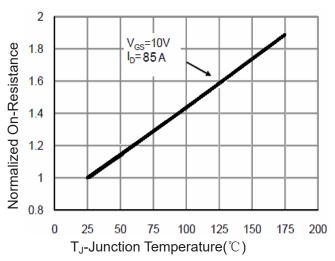


Figure 4 Rdson-Junction Temperature

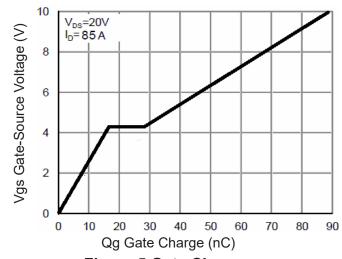


Figure 5 Gate Charge

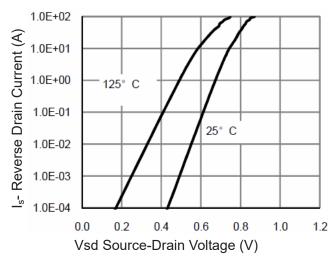
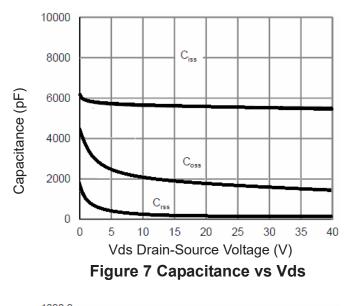
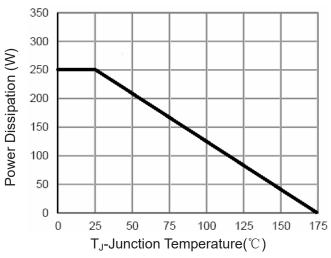


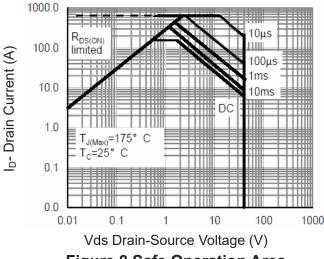
Figure 6 Source- Drain Diode Forward











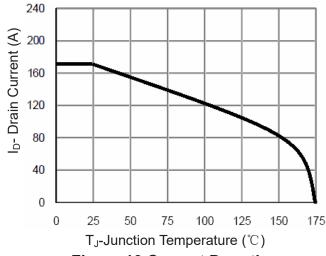


Figure 8 Safe Operation Area

Figure 10 Current De-rating

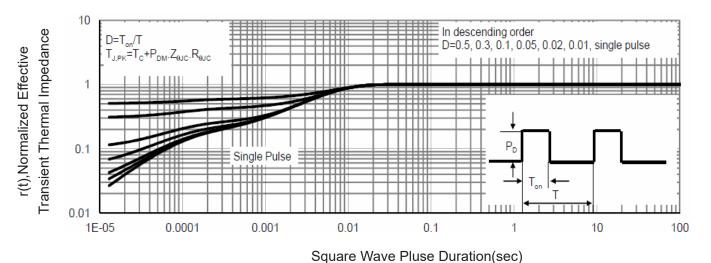


Figure 11 Normalized Maximum Transient Thermal Impedance